

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/672,814	FALSAFI ET AL.
Examiner	Art Unit	
Tae H. Yoon	1714	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
523	115	2/8/07	SC